

General Description

The MY046INE5 use Very low gate charge for high frequency applications, Optimized for dc-dc conversion Excellent gate charge x RDS(on) product (FOM), Very low on-resistance RDS(on), 150 °C operating temperature Pb-free lead plating;

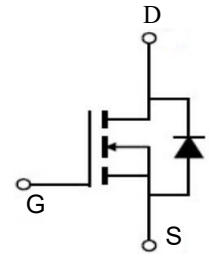
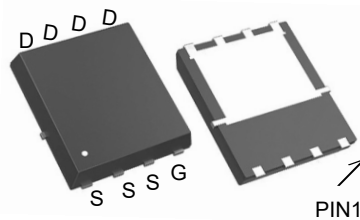


Features

V_{DSS}	100	V
I_D	100	A
$P_D(T_C=25^\circ\text{C})$	156	W
$R_{DS(ON)}(at V_{GS}=10V)$	<4.6	m Ω

Application

- Battery protection
- Load switch
- Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
MY046INE5	PDFN5*6-8L	046IN	5000

Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_C=25^\circ\text{C}$	100	A
		$T_C=100^\circ\text{C}$	85	
		$T_A=25^\circ\text{C}, R_{thJA}=50\text{ K/W}^{(2)}$	17.0	
Pulsed drain current ⁽³⁾	$I_{D,pulse}$	$T_C=25^\circ\text{C}$	400	
Avalanche energy, single pulse	E_{AS}	$I_D=50\text{ A}, R_{GS}=25\ \Omega$	350	mJ
Gate source voltage	V_{GS}		± 20	V
Power dissipation	P_{tot}	$T_C=25^\circ\text{C}$	156	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1			55/150/56	

Electrical Characteristics ($T_J=25\text{ }^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	0.8	K/W
Thermal resistance, junction - ambient	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ²⁾	-	-	50	
Electrical characteristics, at T_j =25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$	100	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=120\text{ }\mu\text{A}$	2	2.7	3.5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=100\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ }^{\circ}\text{C}$	-	0.01	1	μA
		$V_{DS}=100\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=125\text{ }^{\circ}\text{C}$	-	10	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}$, $I_D=50\text{ A}$	-	4	4.6	mΩ
		$V_{GS}=6\text{ V}$, $I_D=25\text{ A}$	-	5.1	8.6	
Gate resistance	R_G		-	1.9	-	Ω
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=50\text{ A}$	48	96	-	S

¹⁾ J-STD20 and JESD22

²⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

³⁾ see figure 3

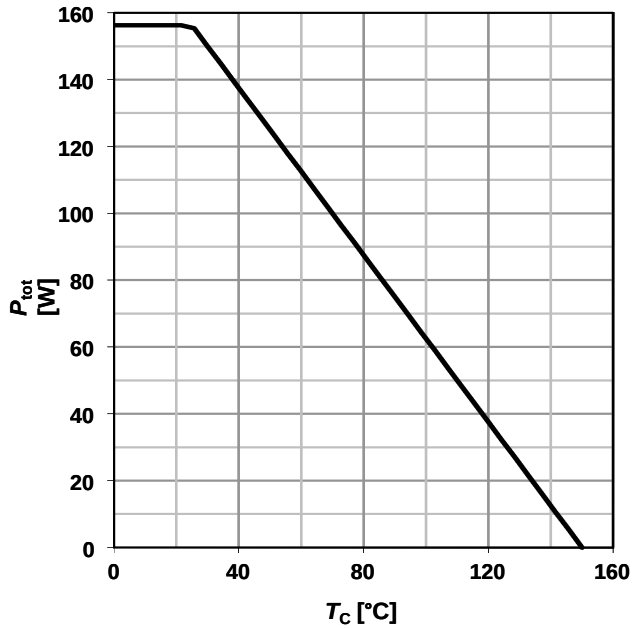
Typical Characteristics

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=50\text{ V}, f=1\text{ MHz}$	-	4500	-	pF
Output capacitance	C_{oss}		-	790	-	
Reverse transfer capacitance	C_{rss}		-	30	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=50\text{ V}, V_{GS}=10\text{ V}, I_D=25\text{ A}, R_G=1.6\text{ }\Omega$	-	16	-	ns
Rise time	t_r		-	14	-	
Turn-off delay time	$t_{d(off)}$		-	41	-	
Fall time	t_f		-	11	-	
Gate Charge Characteristics ⁴⁾						
Gate to source charge	Q_{gs}	$V_{DD}=50\text{ V}, I_D=50\text{ A}, V_{GS}=0\text{ to }10\text{ V}$	-	20	-	nC
Gate to drain charge	Q_{gd}		-	11	-	
Switching charge	Q_{sw}		-	19	-	
Gate charge total	Q_g		-	63	-	
Gate plateau voltage	$V_{plateau}$		-	4.4	-	V
Output charge	Q_{oss}	$V_{DD}=50\text{ V}, V_{GS}=0\text{ V}$	-	84	-	nC
Reverse Diode						
Diode continous forward current	I_S	$T_C=25\text{ }^{\circ}\text{C}$	-	-	100	A
Diode pulse current	$I_{S,pulse}$		-	-	400	
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_F=50\text{ A}, T_j=25\text{ }^{\circ}\text{C}$	-	1	1.2	V
Reverse recovery time	t_{rr}	$V_R=50\text{ V}, I_F=25\text{ A}, di_F/dt=100\text{ A}/\mu\text{s}$	-	56	-	ns
Reverse recovery charge	Q_{rr}		-	101	-	nC

⁴⁾ See figure 16 for gate charge parameter definition

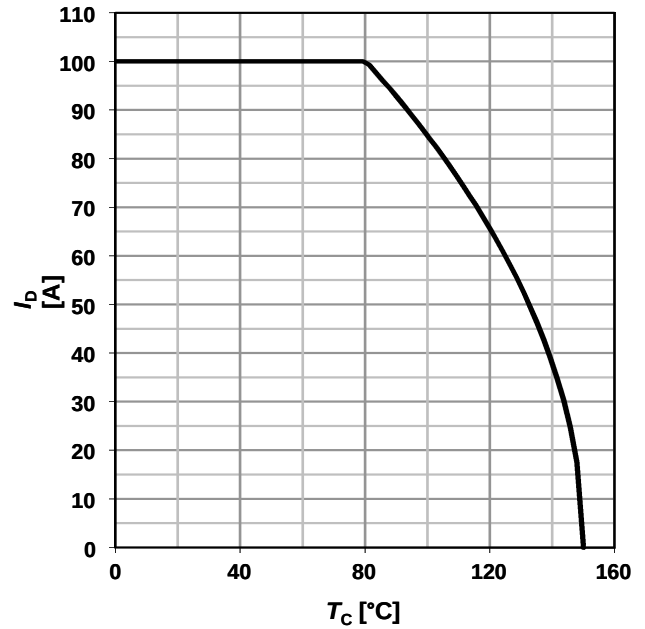
1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$



2 Drain current

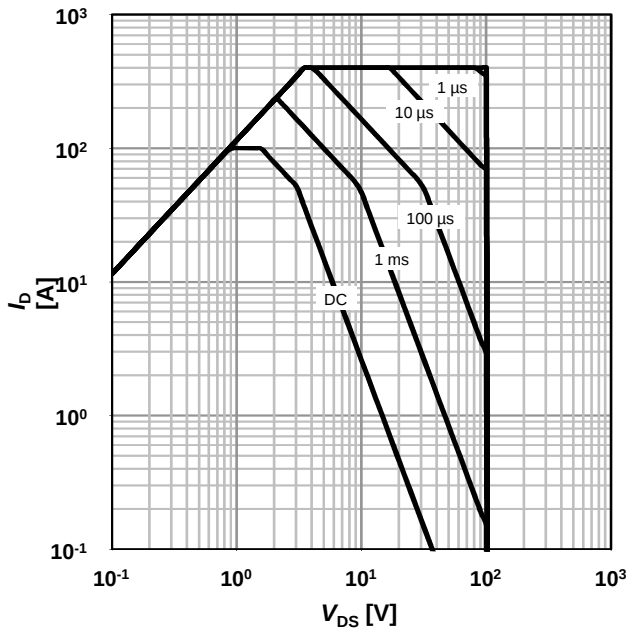
$$I_D = f(T_C); V_{GS} \geq 10 \text{ V}$$



3 Safe operating area

$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

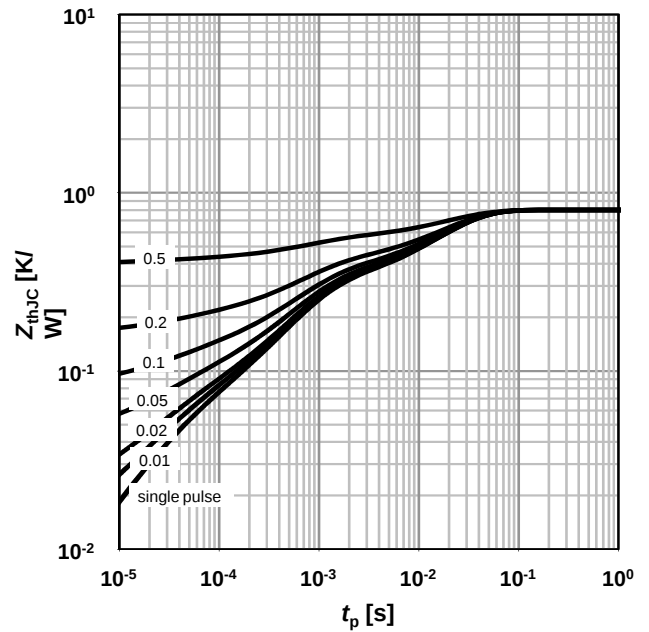
parameter: t_p



4 Max. transient thermal impedance Z

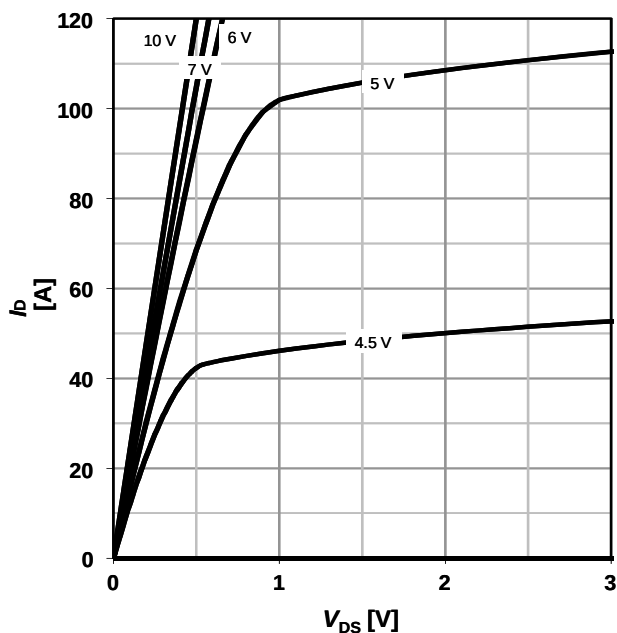
$$Z_{thJC} = f(t_p)$$

parameter: $D = t_p / T$



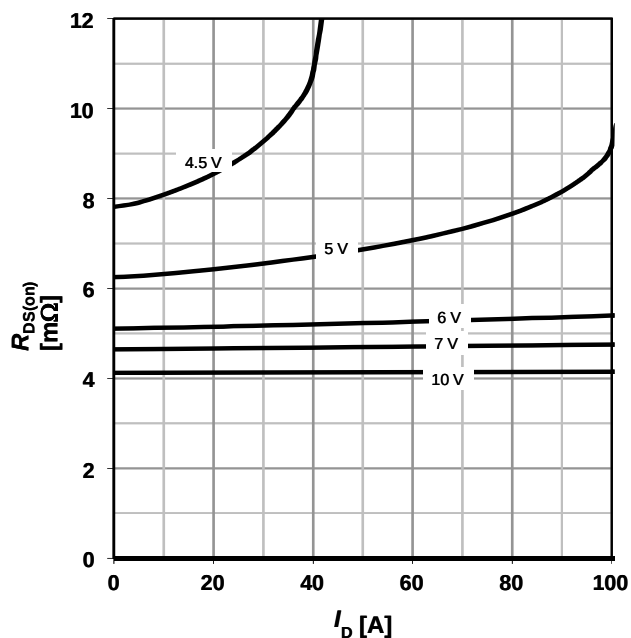
5 Typ. output characteristics /

$I_D = f(V_{DS})$; $T_j = 25^\circ\text{C}$ parameter: V_{GS}



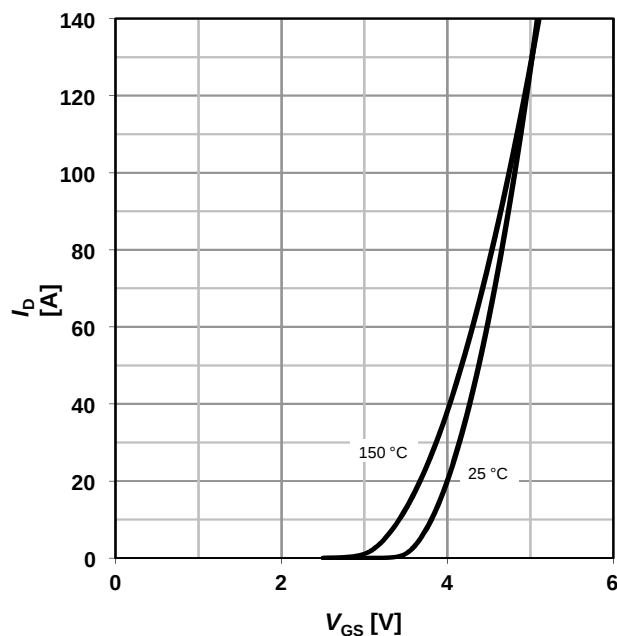
6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$; $T_j = 25^\circ\text{C}$ parameter: V_{GS}



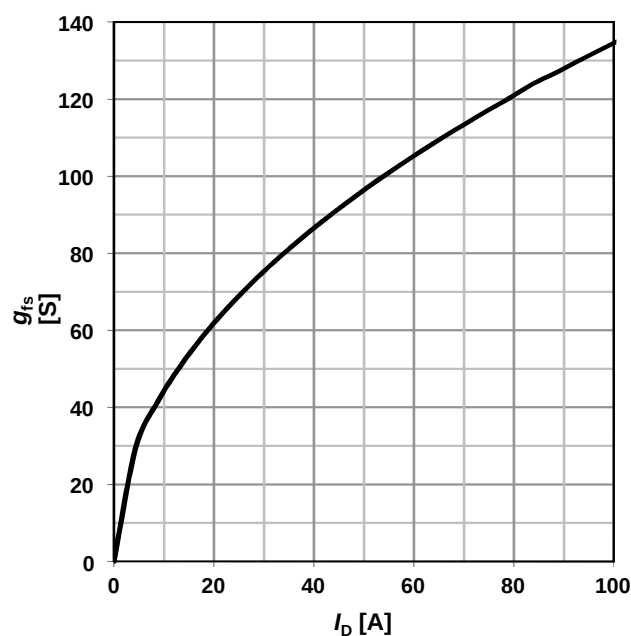
7 Typ. transfer characteristics /

$I_D = f(V_{GS})$; $|V_{DS}| > 2|I_D|R_{DS(on)max}$
parameter: T_j



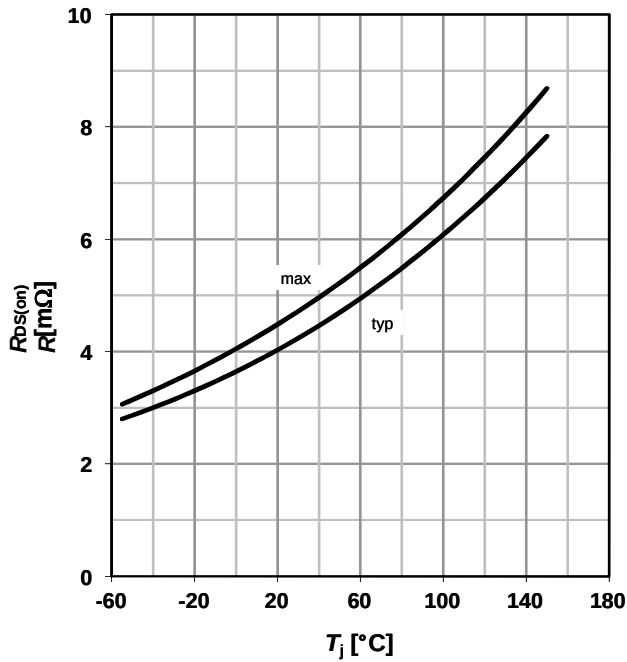
8 Typ. forward transconductance g

$g_{fs} = f(I_D)$; $T_j = 25^\circ\text{C}$



9 Drain-source on-state resistance

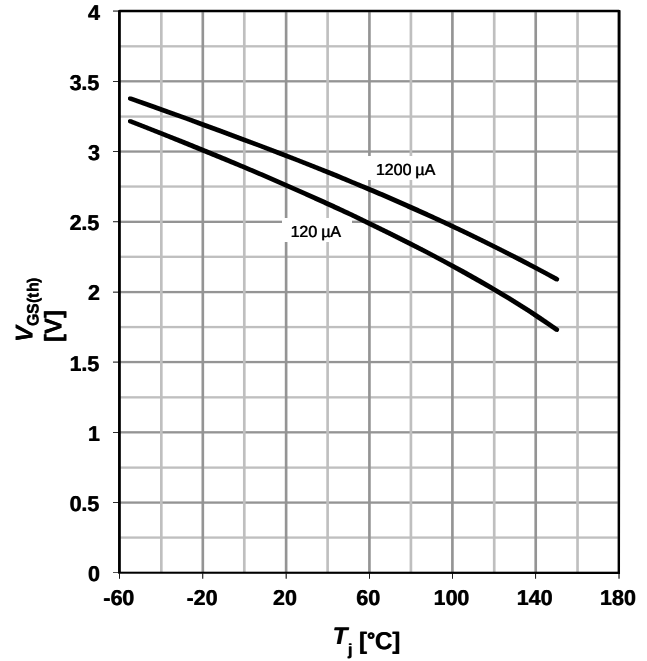
$$R_{DS(on)} = f(T_j); I_D = 50 \text{ A}; V_{GS} = 10 \text{ V}$$



10 Typ. gate threshold voltage

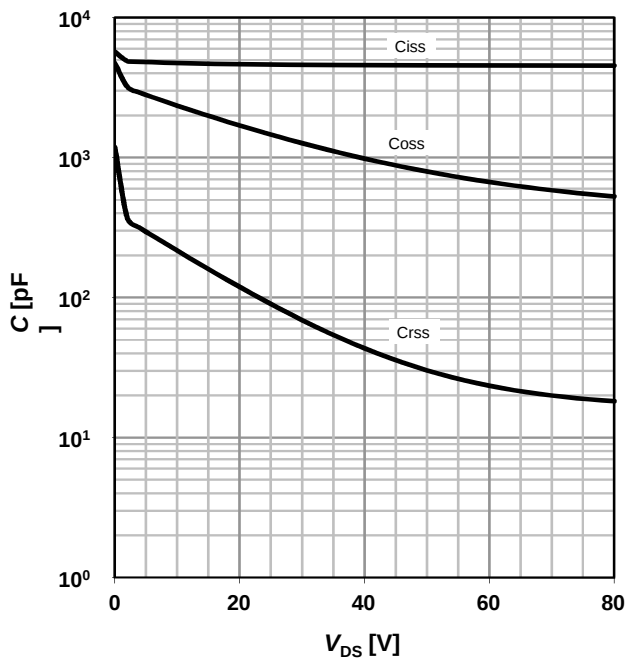
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS} \text{ parameter:}$$

$$I_D$$



11 Typ. capacitances

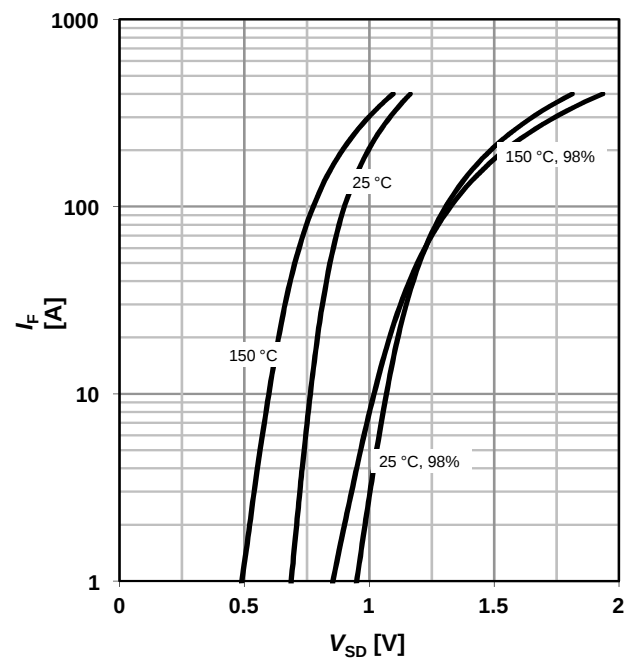
$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$



12 Forward characteristics of reverse diode /

$$I_F = f(V_{SD})$$

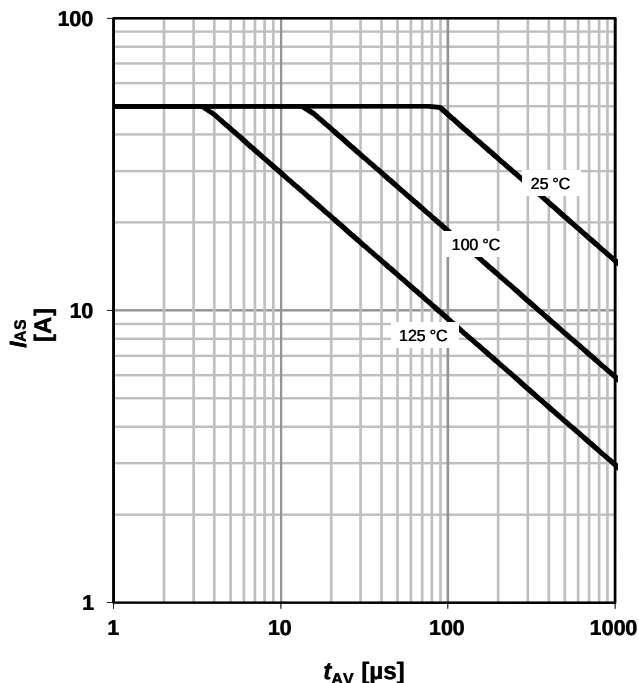
$$\text{parameter: } T_j$$



13 Avalanche characteristics

$I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega$

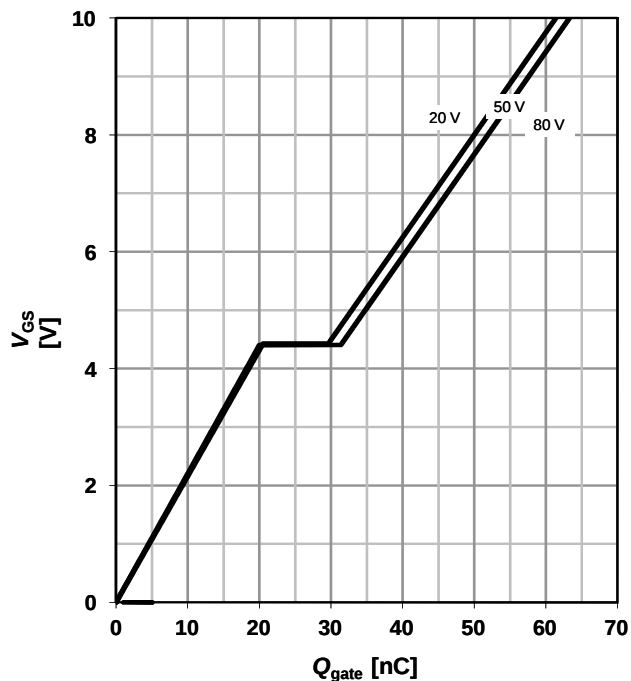
parameter: $T_{j(start)}$



14 Typ. gate charge

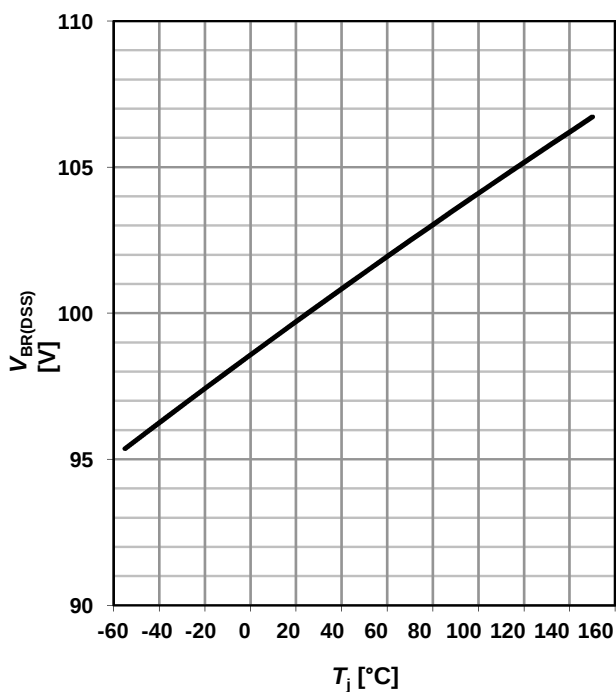
$V_{GS}=f(Q_{gate}); I_D=50\ A$ pulsed

parameter: V_{DD}

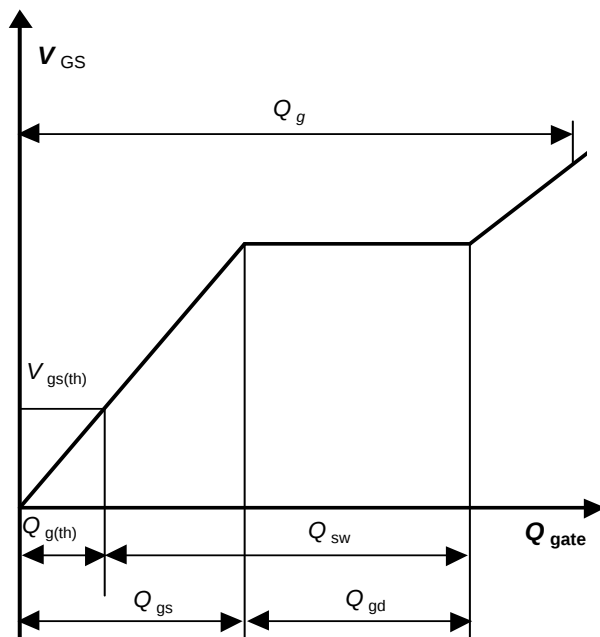


15 Drain-source breakdown voltage $V_{BR(DSS)}$

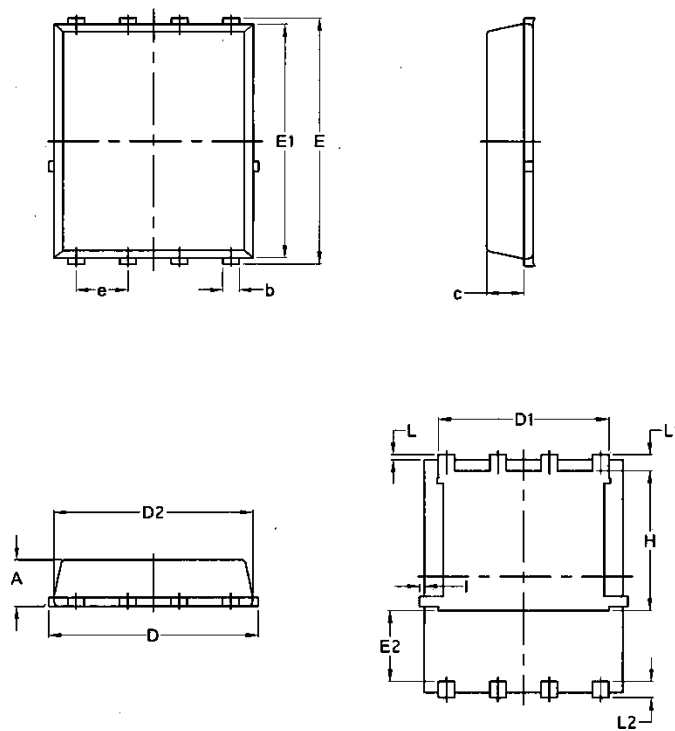
$V_{BR(DSS)}=f(T_j); I_D=1\ mA$



16 Gate charge waveforms



Package Mechanical Data-DFN5*6-8L-JQ Single



Symbol	Common			
	mm		Inch	
	Mim	Max	Min	Max
A	1.03	1.17	0.0406	0.0461
b	0.34	0.48	0.0134	0.0189
c	0.824	0.0970	0.0324	0.082
D	4.80	5.40	0.1890	0.2126
D1	4.11	4.31	0.1618	0.1697
D2	4.80	5.00	0.1890	0.1969
E	5.95	6.15	0.2343	0.2421
E1	5.65	5.85	0.2224	0.2303
E2	1.60	/	0.0630	/
e	1.27 BSC		0.05 BSC	
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.50	0.0150	0.0197
L2	0.38	0.50	0.0150	0.0197
H	3.30	3.50	0.1299	0.1378
I	/	0.18	/	0.0070